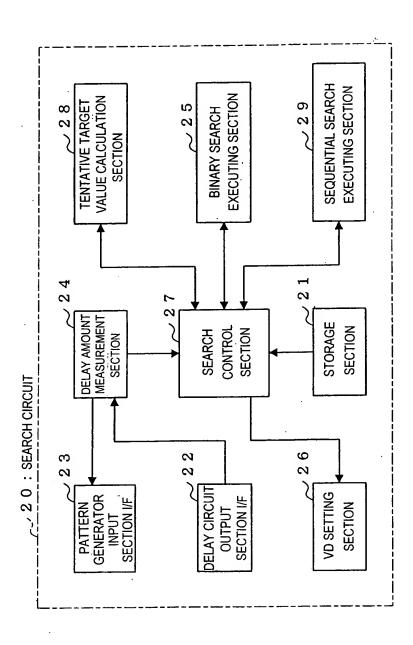
FIG. 1



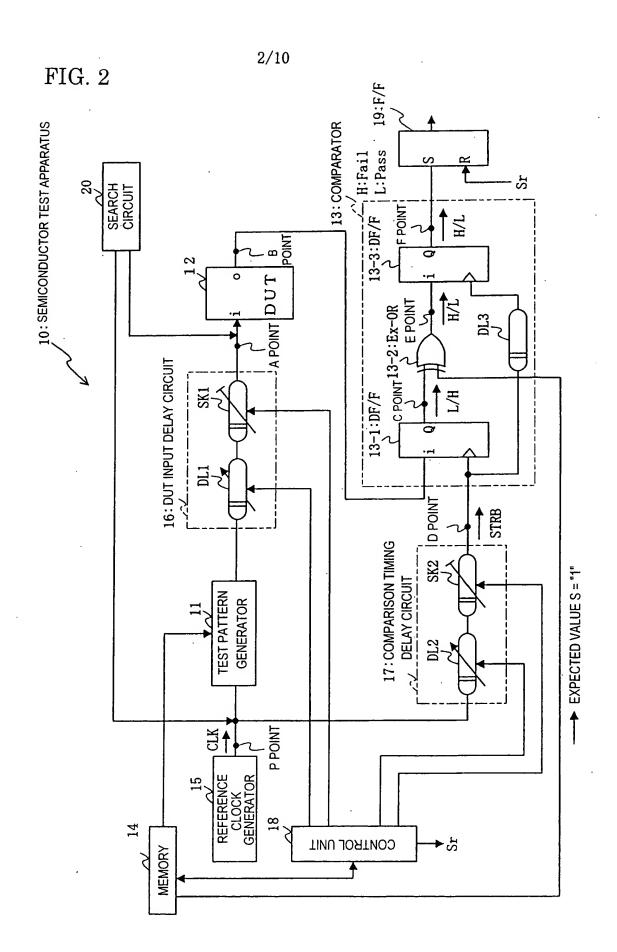
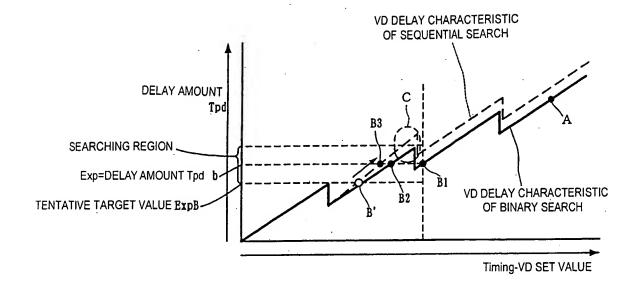


FIG. 3



The state of the s

FIG. 4

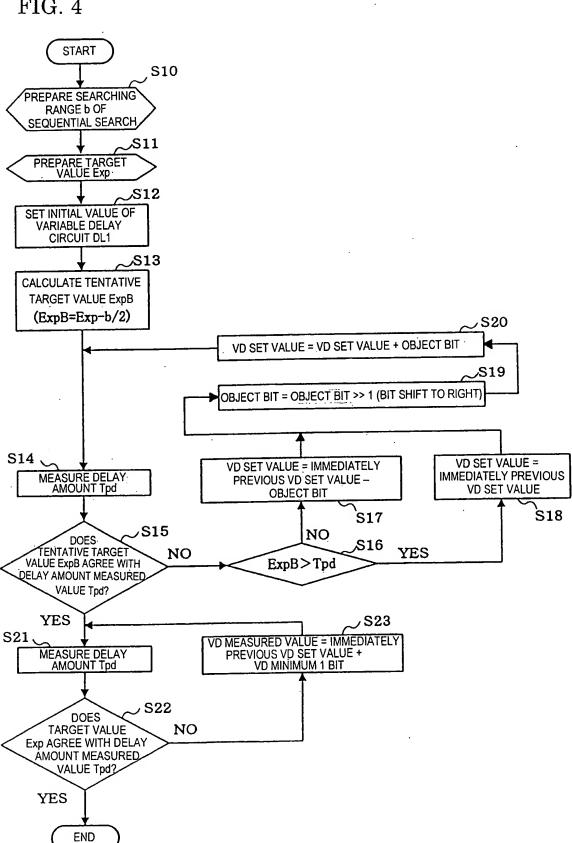
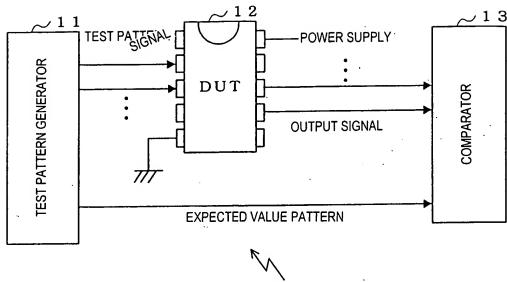
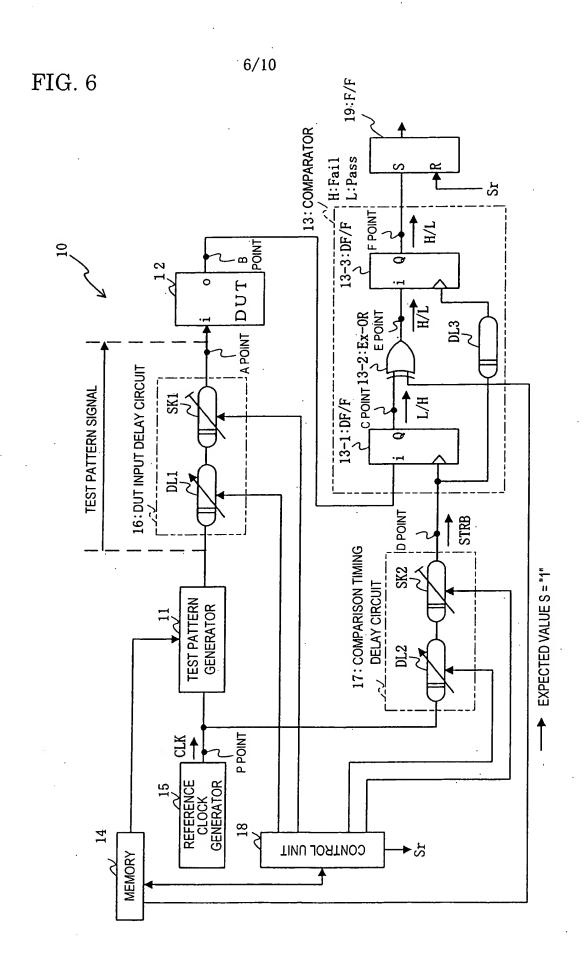


FIG. 5



1 0 : SEMICONDUCTOR TEST APPARATUS



The state of the s

FIG. 7

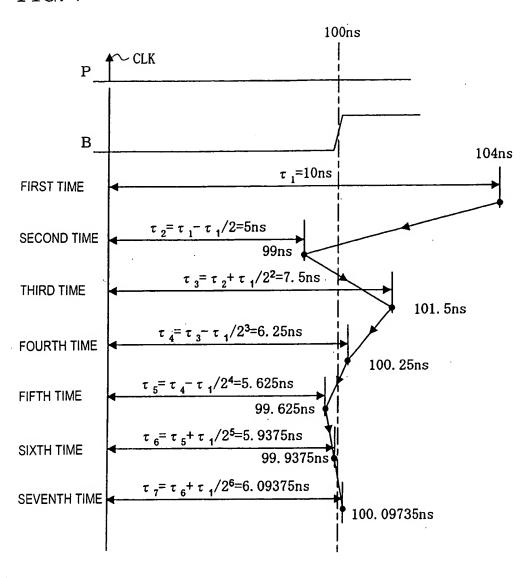


FIG. 8

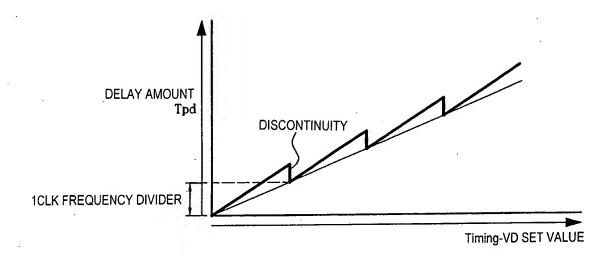


FIG. 9

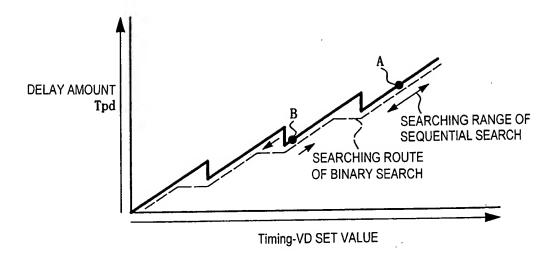


FIG. 10

